

after it has dried or by measuring the radioactivity in the residue obtained by evaporation of the water in which the source was immersed.

(e) *Dry wipe test.* On completion of the preceding test in this section, the dry wipe test described in paragraph (b) of this section shall be repeated.

(f) *Observations.* Removal of more than 0.005 microcurie of radioactivity in any test prescribed by this section shall be cause for rejection of the source design. Results of prototype tests submitted to the Commission shall be given in terms of radioactivity in microcuries and percent of removal from the total amount of radioactive material deposited on the source.

[30 FR 8192, June 26, 1965, as amended at 31 FR 15145, Dec. 2, 1966]

§ 32.103 Schedule D—prototype tests for ice detection devices containing strontium-90.

An applicant for a license pursuant to § 32.61 shall conduct prototype tests on each of five prototype ice detection devices as follows:

(a) *Temperature-altitude test.* The device shall be placed in a test chamber as it would be used in service. A temperature-altitude condition schedule shall be followed as outlined in Step 1 through Step 10 of § 32.101(a).

(b) *Vibration tests.* The device shall be subjected to vibration tests as set forth in § 32.101(b).

(c) *Shock test.* The device shall be subjected to shock test as set forth in § 32.101(d).

(d) *Hermetic seal and waterproof test.* On completion of all other tests prescribed by this section, the device shall be immersed in 30 inches of water for 24 hours and shall show no visible evidence of physical contact between the water and the strontium-90. Absolute pressure of the air above the water shall then be reduced to 1 inch of mercury. Lowered pressure shall be maintained for 1 minute or until air bubbles cease to be given off by the water, whichever is the longer. Pressure shall then be increased to normal atmospheric pressure. Any visible evidence of physical contact between the water and the strontium-90 shall be considered leakage.

(e) *Observations.* After each of the tests prescribed by this section, each device shall be examined for evidence of physical damage and for loss of strontium-90. Any evidence of leakage or damage to or failure of any device which could affect containment of the strontium-90 shall be cause for rejection of the design if the damage or failure is attributable to a design defect. Loss of strontium-90 from each tested device shall be measured by wiping with filter paper an area of at least 100 square centimeters on the outside surface of the device, or by wiping the entire surface area if it is less than 100 square centimeters. The amount of strontium-90 in the water used in the hermetic seal and waterproof test prescribed in paragraph (d) of this section shall also be measured. The detection on the filter paper of more than 2,200 disintegrations per minute of strontium-90 per 100 square centimeters of surface wiped or in the water of more than 0.1 percent of the original amount of strontium-90 in any device, shall be cause for rejection of the tested device.

[30 FR 9906, Aug. 10, 1965]

Subpart C—Quality Control Sampling Procedures

§ 32.110 Acceptance sampling procedures under certain specific licenses.

(a) A random sample shall be taken from each inspection lot of devices licensed under §§ 32.14, 32.53, or 32.61 of this part for which testing is required pursuant to §§ 32.15, 32.55, or 32.62 in accordance with the appropriate Sampling Table in this section determined by the designated Lot Tolerance Percent Defective. If the number of defectives in the sample does not exceed the acceptance number in the appropriate Sampling Table in this section, the lot shall be accepted. If the number of defectives in the sample exceeds the acceptance number in the appropriate Sampling Table in this section, the entire inspection lot shall be rejected.

(b) Single sampling tables for Lot Tolerance Percent Defective:

(1) Lot Tolerance Percent Defective 0.5 percent:

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Lot size	Sample size	Acceptance No.
1 to 180	All	0
181 to 210	180	0
211 to 250	210	0
251 to 300	240	0
301 to 400	275	0
401 to 500	300	0
501 to 600	320	0
601 to 800	350	0
801 to 1,000	365	0
1,001 to 2,000	410	0
2,001 to 3,000	430	0
3,001 to 4,000	440	0
4,001 to 5,000	445	0
5,001 to 7,000	450	0
7,001 to 10,000	455	0
10,001 to 20,000	460	0
20,001 to 50,000	775	1
50,001 to 100,000	780	1

(2) Lot Tolerance Percent Defective 1.0 percent:

Lot size	Sample size	Acceptance No.
1 to 120	All	0
121 to 150	120	0
151 to 200	140	0
201 to 300	165	0
301 to 400	175	0
401 to 500	180	0
501 to 600	190	0
601 to 800	200	0
801 to 1,000	205	0
1,001 to 3,000	220	0
3,001 to 5,000	225	0
5,001 to 10,000	230	0
10,001 to 100,000	390	1

(3) Lot Tolerance Percent Defective 2.0 percent:

Lot size	Sample size	Acceptance No.
1 to 75	All	0
76 to 100	70	0
101 to 200	85	0
201 to 300	95	0
301 to 400	100	0
401 to 600	105	0
601 to 800	110	0
801 to 4,000	115	0
4,001 to 10,000	195	1
10,001 to 100,000	200	1

(4) Lot Tolerance Percent Defective 3.0 percent:

Lot size	Sample size	Acceptance No.
1 to 40	All	0
41 to 55	40	0
56 to 100	55	0
101 to 200	65	0
201 to 500	70	0
501 to 3,000	75	0
3,001 to 100,000	130	1

(5) Lot Tolerance Percent Defective 4.0 percent:

Lot size	Sample size	Acceptance No.
1 to 35	All	0
36 to 50	34	0
51 to 100	44	0
101 to 200	50	0
201 to 2,000	55	0
2,001 to 100,000	95	1

(6) Lot Tolerance Percent Defective 5.0 percent:

Lot size	Sample size	Acceptance No.
1 to 30	All	0
31 to 50	30	0
51 to 100	37	0
101 to 200	40	0
201 to 300	43	0
301 to 400	44	0
401 to 2,000	45	0
2,001 to 100,000	75	1

(7) Lot Tolerance Percent Defective 7.0 percent:

Lot size	Sample size	Acceptance No.
1 to 25	All	0
26 to 50	24	0
51 to 100	28	0
101 to 200	30	0
201 to 300	31	0
301 to 800	32	0
801 to 1,000	33	0
1,001 to 100,000	55	1

(8) Lot Tolerance Percent Defective 10.0 percent:

Lot size	Sample size	Acceptance No.
1 to 20	All	0
21 to 50	17	0
51 to 100	20	0
101 to 200	22	0
201 to 800	23	0
801 to 100,000	39	1

[39 FR 22130, June 20, 1974]

Subpart D—Specifically Licensed Items

§ 32.210 Registration of product information.

(a) Any manufacturer or initial distributor of a sealed source or device containing a sealed source whose product is intended for use under a specific license may submit a request to NRC